

Notice of References Cited	Application/Control No. 10/518,175	Applicant(s)/Patent Under Reexamination TENEMBAUM ET AL.	
	Examiner Phuoc H. Nguyen	Art Unit 2143	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,954,902 B2	10-2005	Noma et al.	715/753
*	B	US-6,434,599 B1	08-2002	Porter, Swain W.	709/204
*	C	US-5,880,731 A	03-1999	Liles et al.	715/758
*	D	US-2002/0029252 a1	03-2002	Segan et al.	709/217
*	E	US-6,219,045 B1	04-2001	Leahy et al.	709/204
*	F	US-6,784,901 B1	08-2004	Harvey et al.	715/757
*	G	US-6,981,021 B2	12-2005	Takakura et al.	709/204
*	H	US-2001/0051982 a1	12-2001	Graziani, Paul	709/204
*	T	US-2002/0103920 A1	08-2002	Berkun et al.	709/231
*	J	US-2002/0103920 A1	08-2002	Berkun et al.	709/231
*	K	US-2004/0225716 A1	11-2004	Shamir et al.	709/204
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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